



RF Exposure Report

Test report
On Behalf of
Dongguan Xing Yue Electronic Co., Ltd
For
Dual Wireless Charging Pad
Model No.: XO-9540

FCC ID: 2ALCFXO-9540

Prepared for: Dongguan Xing Yue Electronic Co., Ltd

#98 LiWu Swan Industrial District, Qiao Tou Town, Dong Guan, Guang

Dong, China

Prepared By: Shenzhen HUAK Testing Technology Co., Ltd.

1F, B2 Building, Junfeng Zhongcheng Zhizao Innovation Park, Fuhai

Street, Bao'an District, Shenzhen City, China

Date of Test: Oct. 09, 2018 to Oct. 16, 2018

Date of Report: Oct. 16, 2018

Report Number: HK1810101251E





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TEST RESULT CERTIFICATION

Applicant's name:	Donggua	n Xing Yue Electronic Co., Ltd
Address:		u Swan Industrial District, Qiao Tou Town, Dong Guan, ong, China
Manufacture's Name:	Donggua	n Xing Yue Electronic Co., Ltd
Address:		u Swan Industrial District, Qiao Tou Town, Dong Guan, ong, China
Product description		
Trade Mark:	N/A	
Product name:	Dual Wir	eless Charging Pad
Model and/or type reference :	XO-9540	
Standards:	KDB 680	106 D01 RF Exposure Wireless Charging Base App v03
source of the material. Shenzhe	en HUAK for dama lacement	gy Co., Ltd. is acknowledged as copyright owner and Testing Technology Co., Ltd. takes no responsibility for ages resulting from the reader's interpretation of the and context.
Date (s) of performance of tests.	:	Oct. 09, 2018 to Oct. 16, 2018
Date of Issue	:	Oct. 16, 2018
Test Result	:	Pass
Testing Engineer	:	Good Sign
		(Gary Qian)
Technical Manager	:	Edan Hu
		(Eden Hu)
Authorized Signator	·v <u>=</u>	Lagin Thin

(Jason Zhou)



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1. TEST SUMMARY

1.1 TEST PROCEDURES AND RESULTS

DESCRIPTION OF TEST	RESULT
E and H field strength measurements	Compliant

1.2 TEST FACILITY

Test Firm : Shenzhen HUAK Testing Technology Co., Ltd.

Address : 1F, B2 Building, Junfeng Zhongcheng Zhizao Innovation Park,

Fuhai Street, Bao'an District, Shenzhen City, China

Designation Number: : CN1229

Test Firm Registration Number: 616276

1.3 MEASUREMENT UNCERTAINTY

Measurement Uncertainty

Conducted Emission Expanded Uncertainty = 2.23dB, k=2 Radiated emission expanded uncertainty(9kHz-30MHz) = 3.08dB, k=2 Radiated emission expanded uncertainty(30MHz-1000MHz) = 4.42dB, k=2 Radiated emission expanded uncertainty(Above 1GHz) = 4.06dB, k=2



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2. GENERAL INFORMATION

2.1. PRODUCT DESCRIPTION

A major technical description of EUT is described as following

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Operation Frequency	123.8KHz				
Maximum field strength	59.46dBuV/m(Peak)@3m				
Number of channels	1				
Antenna Designation	Integrated Antenna (Met 15.203 Antenna requirement)				
Hardware Version	HTL-HQ030V1				
Software Version	V1.0				
Power Supply	DC5V				



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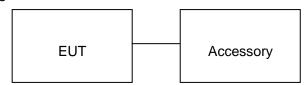
2.2 OPERATION OF EUT DURING TESTING

NO.	TEST MODE DESCRIPTION			
1	Wireless charging Mode(Full load)			
2	Wireless charging Mode(half load)			
3	Wireless charging Mode(Null load)			
Note:				

1. The mode 1 was the worst case and only the data of the worst case record in this report.

2.3 DESCRIPTION OF TEST SETUP





Item	Equipment	Model No.	ID or Specification	Remark
1	Wireless electronic Load	1	10W(5W*2)	Support
2	Adapter	CD05	DC5V	AE





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3. TEST EQUIPMENT LIST

Description	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Broadband Field	Narda Safety Test	NBM-550	J-0004	June 12, 2018	June 11, 2019	
Meter	Solutions GmbH	INDIVI-550	J-000 4	Julie 12, 2016	Julie 11, 2018	
Drobo EUD	Narda Safety Test		1.0045	luna 40, 2040	luna 44 2040	
Probe FHP	Solutions GmbH	EHP-50F	J-0015	June 12, 2018	June 11, 2019	

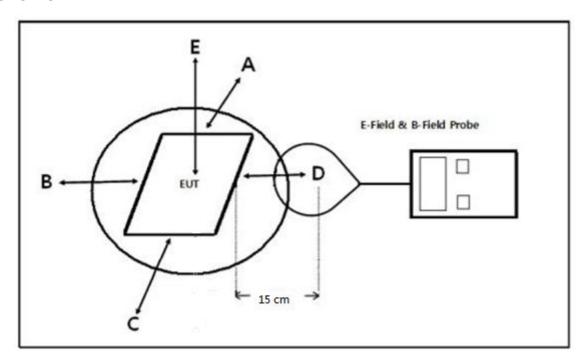
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4. RADIO FREQUENCY (RF) EXPOSURE TEST

4.1. LIMITS

For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 15 cm. E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device. Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m.

4.2. TEST SETUP



Note: Position A: Front of EUT; Position B: Left of EUT; Position C: back of EUT; Position D: Right of EUT; Position E: Top of EUT(15 cm measure distance);



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4.3. TEST PROCEDURE

The EUT was placed on a non-conductive table top and the ancillary equipment (e.g. mobile phone) was placed on the EUT for charging.

Maximum E-field and H-field measurements were tested 15cm from each side of the EUT. For top side the measure distance is 15cm.

Along the side of the EUT to center of E-field probe and H-field probe were positioned at the location to search maximum field strength.

4.4. TEST RESULT

Test condition: Mode 1
E-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(V/m)
	(V/m)	(V/m)	(V/m)	(V/m)	(V/m)	
123.8KHz	0.16	0.16	0.16	0.16	1.95	614

H-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(A/m)
	(A/m)	(A/m)	(A/m)	(A/m)	(A/m)	
123.8KHz	0.14	0.14	0.14	0.14	0.48	1.63

Test condition: Mode 2 E-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(V/m)
	(V/m)	(V/m)	(V/m)	(V/m)	(V/m)	
128.1KHz	0.15	0.15	0.15	0.15	1.54	614

H-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(A/m)
	(A/m)	(A/m)	(A/m)	(A/m)	(A/m)	
128.1KHz	0.19	0.19	0.19	0.19	0.21	1.63



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Test condition: Mode 3 E-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(V/m)
	(V/m)	(V/m)	(V/m)	(V/m)	(V/m)	
138.5KHz	0.15	0.15	0.15	0.15	1.06	614

H-field strength test result:

Frequency	Probe	Probe	Probe	Probe	Probe	Limit
Range	Position A	Position B	Position C	Position D	Position E	(A/m)
	(A/m)	(A/m)	(A/m)	(A/m)	(A/m)	
138.5KHz	0.13	0.13	0.13	0.13	0.18	1.63



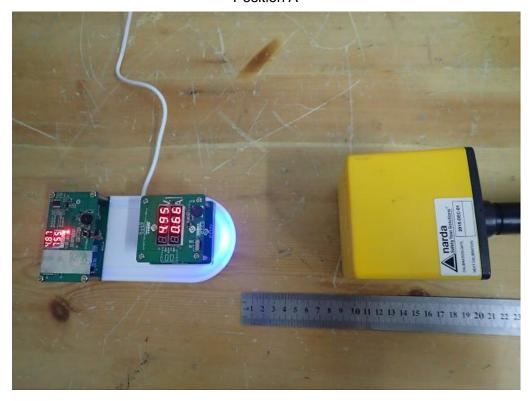
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APPENDIX A: PHOTOGRAPHS OF TEST SETUP

Position E



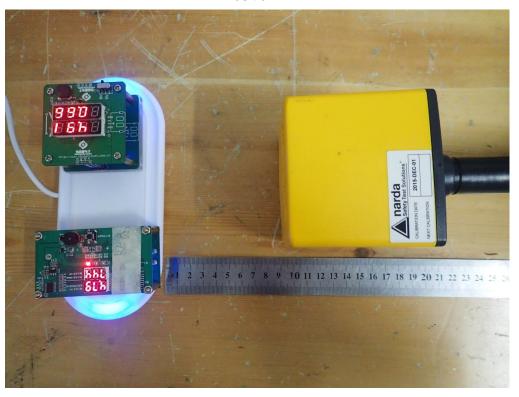
Position A



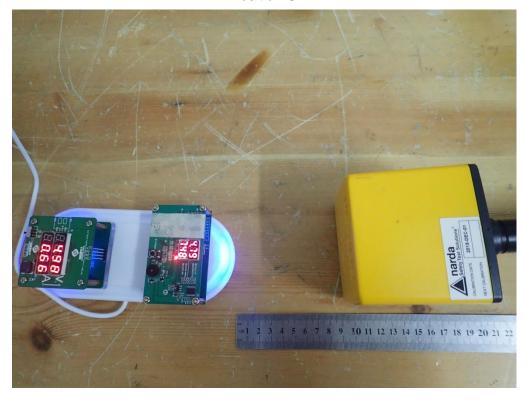


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Position B



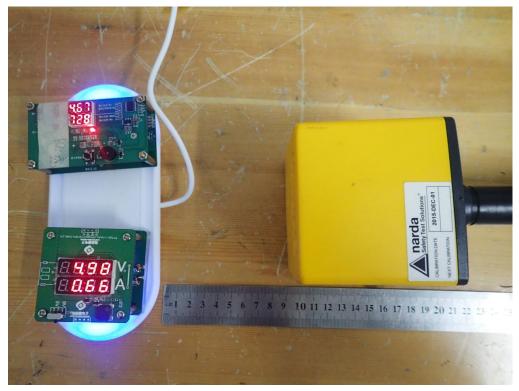
Position C





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Position D



----END OF REPORT----